

Notic of References Cited	Application/Control No. 10/651,137	Applicant(s)/Patent Under Reexamination KOPF ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,039,456	08-1991	Bowen et al.	264/1.25
	B	US-5,475,781	12-1995	Chang et al.	385/76
	C	US-5,898,813	04-1999	Beier, Axel	385/139
	D	US-6,454,464	09-2002	Nolan, Richard G.	385/60
	E	US-6,611,648	08-2003	Kumar et al.	385/126
	F	US-6,634,798	10-2003	Cheng, Yu-Feng	385/76
	G	US-6,707,979	03-2004	Wang et al.	385/140
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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